Random bad cell map for wafer 167 s/n: Y21316-12-01

Date: 07/02/99

		0	0	7				
		2	0		2	7		
		1	6	4	6	5	4	
	0		9	0		6	5	
0	0	0	426	133	48	8		4
0	0	8		378	154	19		
	0	17	271	620	347	47	14	3
0	0	35	613	540	672	112	3	0
0			572	173	529	88	2	
0		61	576	199	513	77	3	
0	0	25	299	241	353	36		0
20	0	6	152	300	167	14	0	0
0	0	1		96	39	2	0	0
	0	0	5	17	8	0	0	
	0	0		1	0	0		
	0	0		0	0	0	0	
				0	0	0		
			0	0	0	0		

#	Number of bad cells in random locations
	No info